QUANTUM EFFICIENCY / IPCE MEASUREMENT SYSTEM

IV TESTING, SPECTRAL RESPONSE & QUANTUM EFFICIENCY SYSTEM / IPCE SYSTEM



Features

- Spectral range 250 2500 nm
- Monochromatic light power up to I25mW total
- Keithley 2400 series source meter
 (Measurement of large capacitance solar cell is possible.)
- Stanford SR800 series lock-in amplifier
- Light-tight measurement chamber
- DC mode measurement capability (optional)

Applications

- IV measurement
- Spectral Response measurement (SR)
- External Quantum Efficiency / IPCE measurement (EQE)
- Internal Quantum Efficiency measurement (IQE)





A. Overview

Photovoltaic devices are so called since they rely upon the photovoltaic effect that was first discovered by a French experimental physicist, Edmund Becquerel, in 1839 to generate a current/voltage upon exposure to light. However, the history of practical PV devices did not begin until 1954 when Bell Laboratory first demonstrated a silicon solar cell with a conversion efficiency of 6%.

Sciencetech Inc. has been designing and manufacturing modular optical spectroscopy instruments and components for over 30 years. They are widely used all over the world in research laboratories, universities and companies. Sciencetech instruments are designed with the researchers in mind and feature fully adjustable controls for research flexibility. All Sciencetech systems incorporate modular design and adherence to industry standards for easy integration with other supplier's instruments and components.

Sciencetech Inc. designs and fabricates four different variants of Photovoltaic Testing System (PTS), as shown in the following table, for implementation of different experimental methods.

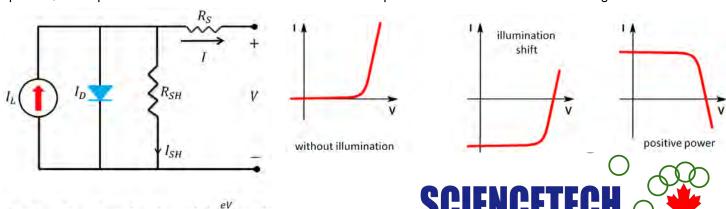
Model	IV Curves	Spectral Re- sponse (SR)	Quantum Efficien- cy (QE / IPCE)	Constant Photocur- rent Method (CPM)	Dual Beam Photoconductiv- ity (DBP)	Steady State Photo Con- ductivity (SSPC)	Internal Quantum Efficiency
PTS-2-QE / IPCE	X	X	X				X (upgrade)
PTS-3-CPM	X	X	Χ	X			X (upgrade)
PTS-3-DBP	X	X	X		X		X (upgrade)
PTS-4-SSPC	X	X	X			X	X (upgrade)

This technical note provides the specific description and features of Sciencetech PTS-2-QE / IPCE system. The PTS-2-QE / IPCE system provides all the capabilities of measuring IV curves, SR, EQE as well as IQE (based on the requirements for upgrading from the customers). Readers interested in CPM, DBP, PTDS and SSPC can refer to our technical notes on PTS-3 and PTS-4 systems, respectively.

The quantities our PTS-2-QE / IPCE system measures are:

- Current-voltage characteristics (IV)

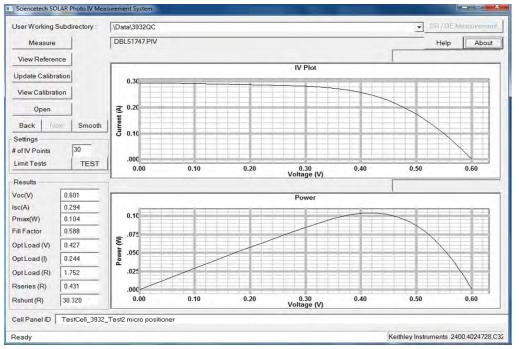
The photocurrent running through a solar cell is the superposition of the current generated by the solar cell under illumination and the current of the solar cell diode in the darkness. The illuminating light has the effect of shifting the IV curve down into the fourth quadrant, where power can be extracted from the diode. The basic equation and IV curves are shown in the figures below.



Parameters are: I_L , the photo current generated by the solar cell that can be used for an external load under illumination; I_D , the net current flowing through the diode; I_0 , the diode's leakage dark saturation current in the absence of light; R_{SH} , a current consuming resistor parallel to the solar cell diode due to manufacturing defects; R_S , a resistor in series with the solar cell circuit due to contact between different metal parts in a solar panel circuit; I_{SH} , the current flowing through the shunt resistor; I_S , the total output current from the solar panel; I_S , the voltage across the cell terminals; I_S , the temperature in Kelvin; I_S and I_S constants for charge of a single electron and Boltzmann constant, respectively; Finally, I_S is the ideality factor.

The effect of a shunt resistance is to consume the cell-generated current so the total output current drops due to this diversion. The effect of a series resistance is to reduce the fill factor, which is a drop in the output power from the solar cell.

A source meter (Keithley 2400) used as an active load permits operating the solar cell under test at various load conditions, including short-circuit, compensating for a series resistor required to sense the current produced by the solar cell from the bias light.

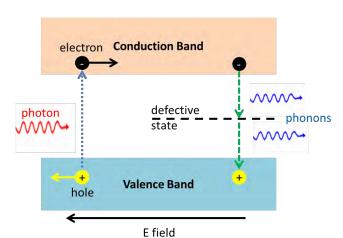


The software controls the source meter to automatically measure the following IV characteristics (an example shown on the left):

- Dark IV
- Open-circuit voltage Voc (as well as Voc slope)
- Short-circuit current lsc
- The maximum power Pmax (Vmax and Imax)
- Fill factor
- Forward and reverse sweep features
- The shunt resistance R_{SH} and R_{S}

- Spectral response (SR)

The spectral response is the ratio of the current generated by the solar cell to the power incident on the solar cell, thus in the unit of A/W. The measurement of SR should be performed using a monochromatic probe beam under simultaneous illumination by a Solar Simulator (SS, i.e., bias light) (ASTM E 1021).



The use of the SS mimics the true operating conditions and is also related particularly to the quality of the material. In poor quality material, the crystal has defective states, where generated carriers lose their energy on phonons and return back to the valence band, leading to incorrect measurement of spectral response, as shown in the figure below. Light from the SS generates a large amount of carriers which help fill/pump the defects/traps so that those carriers generated by the probe beam are not lost.



To distinguish the photocurrent generated from the weaker probe beam from the photocurrent generated from the stronger SS beam, the probe beam is amplitude modulated with the use of an optical chopper. Finally, the SR measurement is performed by focusing a monochromatic beam onto the sample and registering the photocurrent generated as a function of wavelength (as shown in the first figure on page 8). This sensed current plus a reference signal at the frequency of the light modulation (amplitude modulation from the chopper) are both fed into the lock-in amplifier to allow measurement of the photocurrent generated by the modulated monochromatic light.

Unless a different request is made, the geometry of the light from the Monochromator is controlled to illuminate only a small section of the solar cell (typically 3mm diameter), ensuring that 100% of the monochromatic irradiance contributes to the output signal. Sciencetech's QE system also allows users to switch from this "automatic mode" to the "manual mode" for setting their own measurement conditions based on the research requirements.

- External Quantum Efficiency (EQE / IPCE)

External Quantum Efficiency is defined as the ratio of the number of carriers generated and collected by the solar cell to the number of photons of an incident beam without considering the losses due to reflection, transmission, or absorption from the sample. It is usually given as a function of wavelength and has a straightforward relationship with SR as follows:

$$QE = \frac{hc}{e\lambda}SR = \frac{SR * 1240}{\lambda}$$

where the wavelength is in the unit of nm and SR is in A/W.

- Internal Quantum Efficiency (IQE)

Internal Quantum Efficiency is a calculation of the QE with consideration of the losses at the sample, i.e., the ratio of the number of carriers generated and collected by the solar cell to the number of photons that are truly converted by the solar cell.

Instead of attempting to measure the losses directly using an integrating sphere, Sciencetech determines total QE losses by making two QE measurements under different conditions which emphasize external surface effects, allowing losses due to reflection and scattering to be inferred more accurately than would normally be possible to measure. This allows a wider range of sample sizes, and provides accurate, precise information on IQE.

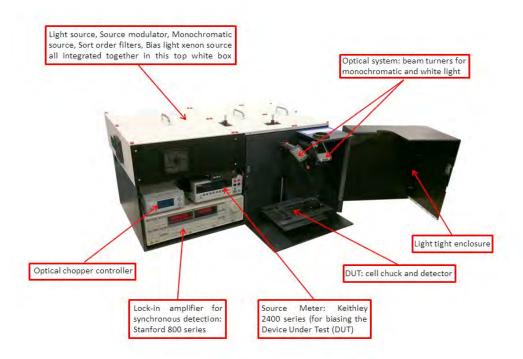


Once the losses are determined the Internal Quantum Efficiency can be simply calculated through the following expression:

$$IQE = \frac{EQE}{1 - losses} = \frac{EQE}{absorption}$$

where losses we measured include the reflection from and the transmission through the sample. Absorption rate is the portion that converts photons to carriers in the sample.





B. Specifications

- Complete SR, QE and IV measurement system with software: The system includes the light source, monochromator with automated order sorting filters, steady-state solar simulator Class AAA, measurement electronics, computer, and software required to measure solar cell characteristics.
- Light tight sample enclosure
- All components are assembled on Sciencetech's integrated optical and electronic mounting system with 54cm x 92cm desktop footprint.
- I Sun low-noise bias light source with AMI.5G filter is included for QE and IV measurements.
- Filter holder is mounted in the optical path, which allows two filters to be mounted in series.
- Manually controlled shutter is included to regulate the light exposure time.
- Bias voltage range is available from 0 to 200V.
- Photocurrent measurement resolution ranges from 10 picoampere to 10 microampere depending on the range.
- Sample enclosure with adjustable dual cell holder and target table of 150mm height adjustment.
- Power system, single phase, can be configurable for 230VAC, 50Hz or 110VAC, 60Hz.
- Shielded and light tight test area enclosure has convenient removable cover allowing access from top, front and sides.

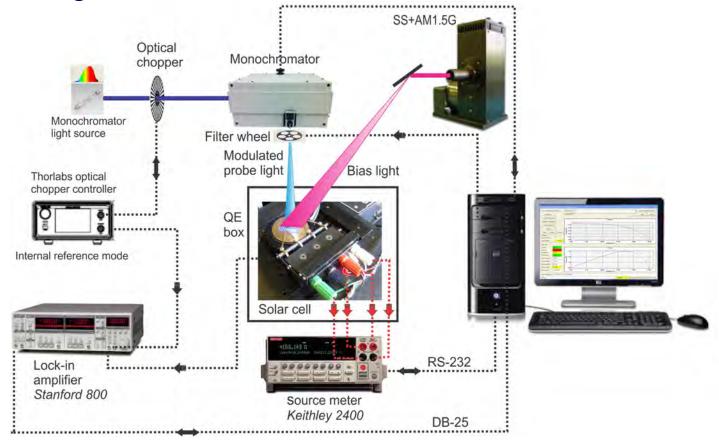


Light Source for Monochromator	 I50W Xe arc lamp or 250W QTH tunable source, average lifetime I200 hours Less than 0.5% instability 250 - 2500nm tuning/scanning range (Xenon) 					
Monochromator	 Czerny-Turner design with adjustable bandpass 0.2 to 10nm Motorized triple grating system Monochromatic probe light power of up to 125mW total (total white light) Adjustable spot size 2mm to 5mm in diameter 					
Order Sorting Filters	 Filters 1, 2, 3, 4 and 5 with cut-on wavelengths at 200nm, 300nm, 500nm, 900nm and 1600nm Filter diameter 25.4mm (1") 					
Bias Light Source	 75W Ultra-stable Xe arc lamp, average lifetime 1200 hours Less than 0.1% instability Adjustable spot size 					
Reference Detector	 5mm diameter, broadband pyroelectric Calibrated range 250 - 2500nm Reference solar cells 20mm x 20mm Specialized chuck 76.2mm x 76.2mm (3" x 3") 					
IV Tester	 Source meter Keithley 2400 Maximum electric power reading 20W Maximum voltage 200V and maximum current IA Voltage accuracy 0.015% and current accuracy 0.22% Measurement time period for 100 IV points is 44s 					
Data Acquisition	 Stanford Lock-in Amplifier SR800 series Collected data exportable as ASCII file compatible with MS Windows Chopper I-200Hz 					
Interface	RS-232 (at least I hardware serial port) and USB					
System Dimensions	• 92cm x 54cm x 54cm (36" x 21" x 21")					

	• IEC 60904-1 Measurement of photovoltaic IV characteristics
	ASTM E 1036 Standard test methods for electrical performance of nonconcentrator terrestrial photovol-
Standards	taic modules and arrays using reference cells
	ASTM E 1021-15 Standard test method for spectral responsivity measurements of photovoltaic devices
	• IEC 60904-8 Method for spectral responsivity measurements of a photovoltaic device



C. Configuration



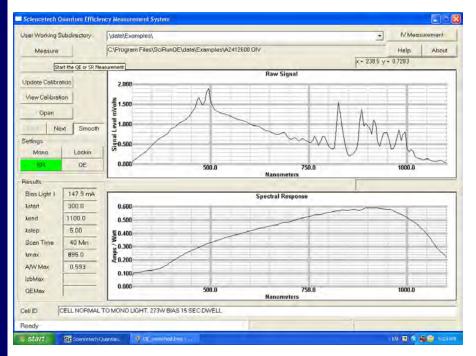
D. Optional specifications and accessories

Monochromatic Light Source	 An option to concentrate light spot in a 1mm x 4mm rectangle for rectangular samples.
Temperature controlled vacuum chuck with probes	 15.2cm x 15.2cm (6" x 6") maximum sample size inside standard chamber and minimum cell size 3.8cm x 3.8cm (1.5" x1.5") For automated stage a specific chuck size could be customized Brass plated tin; Optional: gold plate, gold or nickel coating Temperature Controlled range -10°C - 80°C
Bias Light	Adjustable irradiance up to 5 Suns
Dual light source system	Combined Tungsten and Xenon lamps for higher light efficiency
Automated Stage	 Customized X-Y-Z translation stage and probe station for automated characterization using PTS system

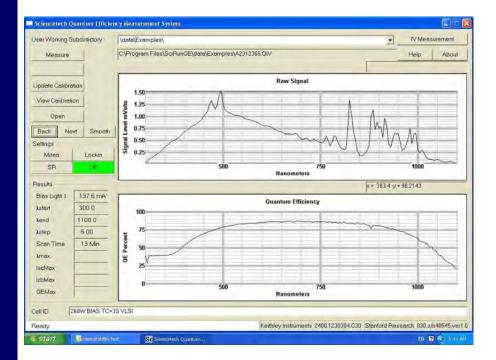


E. Software features

The PTS-2-QE / IPCE system comes with a fully integrated software package, capable of controlling every aspect of the system:

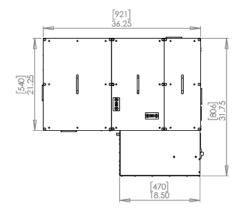


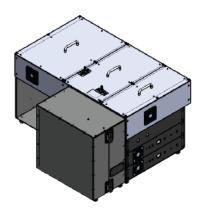
- MS Windows based
- Automation of data acquisition with simple command scripts
- Data acquisition and automation log-keeper data stored in ASCII format
- Visualization corresponds to LabVIEW standards.
- Graphical and data output can be in a wide range of file types.
- Sciencetech may supply source code to customers that wish to further modify the system or integrate it into existing computer framework.

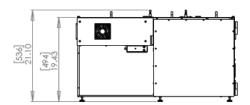


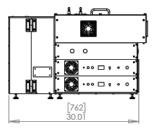


F. Dimensions (inch and mm)









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